

Symposium | Symposium planned by Program Committee | Beyond vacuum condition: challenges in electron/ion-based analysis in real environments

[19p-F7-1~7]Beyond vacuum condition: challenges in electron/ion-based analysis in real environments

Wed. Mar 19, 2014 2:00 PM - 5:30 PM F7 (F307)

△ : Young Scientist Oral Presentation Award Applied

▲ : English Presentation

▼ : Both Award Applied and English Presentation

2:15 PM - 2:45 PM

[19p-F7-2]Recent Development of Environmental TEM (ETEM) for Materials Characterization under Real Environment

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Keywords:環境制御電顕,ETEM,触媒